

**RELIABILITY MONITOR REPORT  
FOR**

**1.2  $\mu\text{m}$  Process**

**Dallas Semiconductor**

**4401 South Beltwood Parkway  
Dallas, TX 75244-3292**

**This Report was prepared by  
Dallas Semiconductor Reliability Engineering**

**Summary:**

The data in the tables that follow was generated as the result of an on-going Process Reliability Monitor. The products covered by this process monitor are:

DS1000	DS1004	DS1012	DS1040	DS1045
DS1202	DS1205	DS1233	DS1267	DS1336
DS1380	DS1384	DS14285	DS1589	DS1602
DS1609	DS1610	DS1620	DS1632	DS1640
DS1648	DS1666	DS1669	DS1688	DS1689
DS1820B	DS1833	DS1867	DS1869	DS2016
DS2107A	DS2130	DS2143	DS2164	DS2165
DS2404	DS2435	DS5001	DS5002	DS50C302
DS9502	DS9503			

The calculated failure rate for devices using this process is

**FAILURE RATE:**                      **MTTF (YRS): 24308**                      **FITS: 4.7**

The parameters used to calculate this failure rate are as follows:

**Cf: 60%**                      **Ea: 0.7**                      **B: 0**                      **Tu: 25 °C**                      **Vu: 5.5 Volts**

The reliability data follows. At the start of this data is the process information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available. This report covers data between 12/31/05 and .

**Device Information:**

Process:                                      1.2 µm Process  
Interconnect:                                Aluminum / 1% Silicon / 0.5% Copper  
Gate Oxide Thickness:                      225 Å

**OPERATING LIFE**

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
HIGH TEMP OP LIFE	0452	DS1644	85 C, 5.5V (PSA) & 0.0V (PSB)	1000 HRS	77	0	
HIGH TEMP OP LIFE	0512	DS1669	125C, 5.5 VOLTS	1000 HRS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
HIGH TEMP OP LIFE	0513	DS1669	125C, 5.5 VOLTS	1000 HRS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
HIGH TEMP OP LIFE	0514	DS1669	125C, 5.5 VOLTS	1000 HRS	45	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
<b>Total:</b>						<b>0</b>	

**STORAGE LIFE**

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
STORAGE LIFE	0512	DS1669	150C	1000 HRS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
STORAGE LIFE	0513	DS1669	150C	1000 HRS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
STORAGE LIFE	0514	DS1669	150C	1000 HRS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	

**Total: 0**

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**TEMPERATURE CYCLE**

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
TEMP CYCLE	0452	DS1644	-40 TO 85C	1000 CYS	77	0	
TEMP CYCLE	0512	DS1669	-55C TO 125C	1000 CYS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
TEMP CYCLE	0513	DS1669	-55C TO 125C	1000 CYS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
TEMP CYCLE	0514	DS1669	-55C TO 125C	1000 CYS	76	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
<b>Total:</b>						<b>0</b>	

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**TEMPERATURE HUMIDITY BIAS**

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
BIASED MOISTURE	0512	DS1669	85/85, 5.5 VOLTS	1000 HRS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
BIASED MOISTURE	0513	DS1669	85/85, 5.5 VOLTS	1000 HRS	77	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
BIASED MOISTURE	0514	DS1669	85/85, 5.5 VOLTS	1000 HRS	45	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
<b>Total:</b>						<b>0</b>	

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**UNBIASED MOISTURE RESISTANCE**

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
MOISTURE SOAK	0452	DS1644	60C/90% R.H.	1000 HRS	77	0	
AUTOCLAVE	0512	DS1669	121C, 2 ATM STEAM, UNBIASED	168 HRS	82	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
AUTOCLAVE	0513	DS1669	121C, 2 ATM STEAM, UNBIASED	168 HRS	83	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
AUTOCLAVE	0514	DS1669	121C, 2 ATM STEAM, UNBIASED	168 HRS	66	0	
VISUAL INSPECTION			WHISKERS < 50uM		3	0	
<b>Total:</b>						<b>0</b>	

**FAILURE RATE:**

**MTTF (YRS): 24308**

**FITS: 4.7**